Issue Classification	Application/Control No.	Applicant(s)/Patent under Reexamination	
‖‖‖‖‖‖ (barcode)	10/719,743	NEW ET AL.	
	Examiner	**Art Unit**	
	Hai L. Nguyen	2816	

ISSUE CLASSIFICATION

ORIGINAL		CROSS REFERENCE(S)							
CLASS	**SUBCLASS**	**CLASS**	**SUBCLASS (ONE SUBCLASS PER BLOCK)**						
327	158	327	161	261					
INTERNATIONAL CLASSIFICATION									
H 0 3 L	7/06								
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	/								
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Hai L. Nguyen 5/09/2006 (Assistant Examiner) (Date)	TIMOTHY P. CALLAHAN SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2800	**Total Claims Allowed: 23**	
(signature) 5/15/06 (Legal Instruments Examiner) (Date)	(Primary Examiner) (Date)	O.G. Print Claim(s): 1	O.G. Print Fig.: 2

☐ Claims renumbered in the same order as presented by applicant   ☐ CPA   ☐ T.D.   ☐ R.1.47

Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original
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	~~3~~		33		63		93		123		153		183
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	~~10~~		40		70		100		130		160		190
9	11		41		71		101		131		161		191
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	29		59		89		119		149		179		209
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